

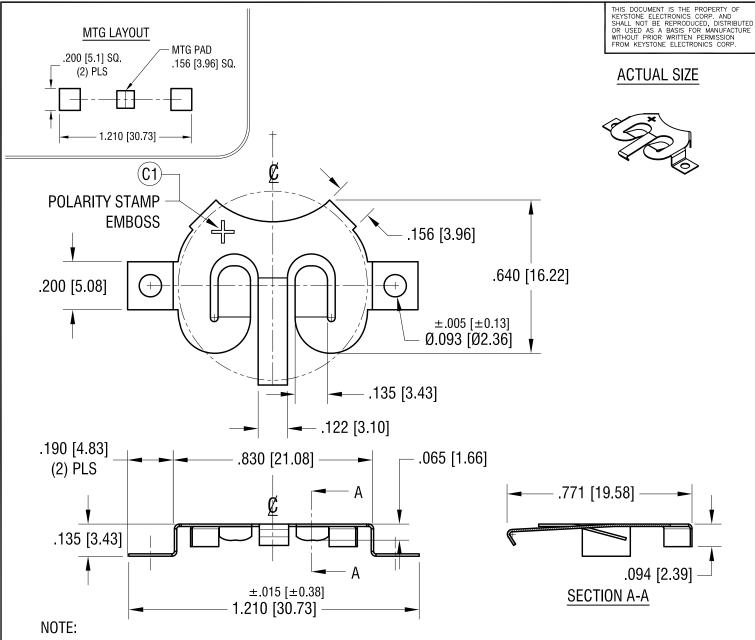
- 1. NO DISLODGMENT OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:
 - a) INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
 - b) SHOCK TEST PER MIL-STD-810G METHOD 516.6
 - c) BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
 - d) TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6
- 2. TAPE AND REEL SPECIFICATIONS:
 - a) TAPE:

b) REEL:

MAT'L - ALL CONDUCTIVE POLYSTYRENE CARRIER ANSI/EIA-481 STANDARD

13.0 [330.2] DIA. 500 PIECES OF PART NO. 2898 PER REEL. 3.30.20 ECN 20-032 ADD NOTE 1. DATE **DESCRIPTION** REV.

KEYSTONE ELECTRONICS CORP. www.keyelco.com • NEW HYDE PARK, NY 11040 • Tel (516) 328-7500 PART NAME SM COIN CELL CLIP ON TAPE MATERIAL AS NOTED DRN BY FINISH DATE 9.19.18 NT AS NOTED APP'D LN INCH [MM] CODE TOLERANCES DWG NO. $\pm .015 [\pm 0.38]$ DECIMAL 2898TR C ANGULAR ± 1° UNLESS OTHERWISE SPECIFIED



- 1. NO DISLODGMENT OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:
 - a) INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
 - b) SHOCK TEST PET MIL-STD-810G METHOD 516.6
 - c) BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
 - d) TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6

DATE	DESCRIPTION	REV.	DECIMAL ± .010 [± 0.25] ANGULAR ± 1° UNLESS OTHERWISE SPECIFIED C 2898
5.13.19	REMOVE DIMPLES CHANGE AS PER ECN 19-053	A	TIN NICKEL PLATE APP'D RH SCALE 2.5X TOLERANCES INCH [MM] CODE DWG NO.
3.30.20	ADDED NOTE 1. CHANGE AS PER ECN 20-031	В	.010 [0.25] TH'K PHOSPHOR BRONZE FINISH TINI NICKEL DI ATE DRN BY NT DATE 9.19.18
1.11.23	STAMP C1 WAS CUT THRU CHANGE AS PER ECN 23-026	С	KEYSTONE ELECTRONICS CORP. www.keyelco.com • NEW HYDE PARK, NY 11040• Tel (516) 328-7500 PART NAME 2032 COIN CELL SM RETAINER MATERIAL